

Applicant: Yuichi Akage et al.
 Serial No.: 10/576,627
 Filing Date: April 21, 2006
 For: ELECTRODE PAD ON CONDUCTIVE SEMICONDUCTOR SUBSTRATE

Confirmation No.: 5766
 Att'y Docket No.: 14321.83
 Art Unit: 2873

INFORMATION DISCLOSURE CITATIONS MADE BY APPLICANT

U.S. Patent Documents

Examiner <u>Initial*</u>	Document <u>Number</u>	Issue <u>Date</u>	Name
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Foreign Patent Documents

Examiner <u>Initial*</u>	Document <u>Number</u>	Publication <u>Date</u>	Country or <u>Patent Office</u>	Translation
/RP/ 1	06-013438	01/21/1994	Japan	No
/RP/ 2	2003-023010	01/24/2003	Japan	No

Other Documents

(including author, title, pertinent pages, etc.)

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/RP/ 3

M.N. Khan et al., *Theoretical Prediction and Experimental Verification of Quantum Well Electroabsorption Modulators with Bandwidths Exceeding 40 GHz*, OFC99, paper ThT4-1/293.

Examiner: /Roy Potter/ (10/14/2008)

Date Considered: 10/14/2008

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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References Cited by Applicants

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Examiners will consider all citations submitted in conformance with 37 C.F.R. § 1.98 and MPEP Sec. 609 and place their initials adjacent the citations in the spaces provided on this form. Examiners will also initial citations not in conformance with the guidelines which may have been considered. A reference may be considered by the Examiner for any reason whether or not the citation is in full conformance with the guidelines. A line will be drawn through a citation if it is not in conformance with the guidelines AND has not been considered. A copy of the submitted form, as reviewed by the Examiner, will be returned to the applicant with the next communication. The original of the form will be entered into the application file.

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The reference designations "A1," "A2," etc. (referring to Applicant's reference 1, Applicant's reference 2, etc.) will be used by the Examiner in the same manner as Examiner's reference designations "A," "B," "C," etc. on Office Action Form PTO-1142.

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Examiner: /Roy Potter/ (10/14/2008)

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